Gallium Nitride E-mode HEMT
GS650EDC090B: 90 mΩ, 650V

Description

Gallium Nitride High-Electron-Mobility Transistors (HEMTs) have shown outstanding results in high power applications. The large bandgap results in a high breakdown field, allowing for high operating voltages. Its inherent two-dimensional electron gas (2-DEG) at the AlGaN/GaN interface yields a high electron sheet charge density and mobility, significantly reducing resistive losses in power transistors. Additionally, due to the low gate charge and reverse recovery charge, the switching losses are reduced and switching speeds increased compared to traditional silicon power devices. The p-GaN gate is implemented to ensure the desired enhancement mode (normally-off) operation and improved slew rates.

The GS650EDC090B can be delivered as separate dice in waffle pack or packaged in a PDFN 8x8 or PDFN 5x6 with exposed paddle allowing an excellent thermal contact.

Features

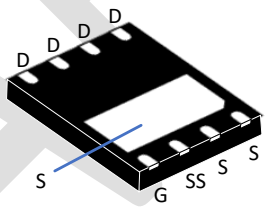
- 650V enhancement mode power transistor
- 850V transient drain-to-source voltage
- Rds,on(typ) = 90 mΩ
- Ids,max = 16,7 A
- Ultra-low FOM
- Simple gate drive requirements: 0 to 6 V
- Transient tolerant gate drive: -20 V / +10 V
- High switching frequency > 1 MHz
- Reverse conduction capability
- Zero reverse recovery loss

Applications

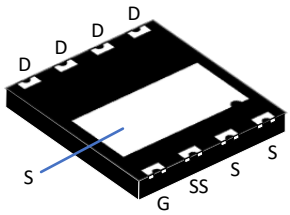
- Wall wart adapters
- Power Factor Correction
- LED drivers
- Battery Chargers
- Industrial Power Supplies
- Motor drivers

Outline

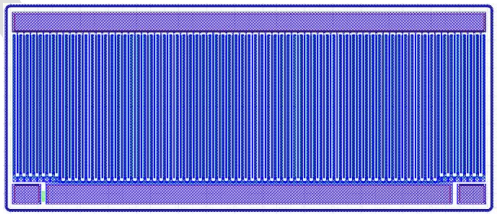
PDFN 5x6



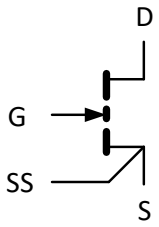
PDFN 8x8



Die



Symbol



Ordering

The GS650EDC090B is not a product for sale. It is a product sample to demonstrate the capabilities of the Power GaN process.

Absolute Maximum Ratings (T_J = 25°C unless otherwise noted)

Table 1

Parameter	Symbol	Value	Unit
Operating Junction Temperature	T_J	-55 to +150	°C
Drain to Source Voltage	V_{DS}	650	V
Drain to Source Voltage – transient (note 1)	$V_{DS,trans}$	850	V
Gate to Source Voltage	V_{GS}	-10 to +7	V
Gate to Source Voltage – transient (note 1)	$V_{GS,trans}$	-20 to + 10	V
Drain Current – continue	I_{DS}	16,7	A
Pulsed Drain Current (note 2)	$I_{DS,P}$	33,4	A

(1) For t ≤ 1 μs
(2) Pulse width 10 μs, V_{GS} = 6 V

Thermal Characteristics PDFN 8x8 (Typical Values unless otherwise noted)

Table 2

Parameter	Symbol	Value	Unit
Thermal Resistance Junction – to – Case	$R_{\Theta\text{-}JC}$	1,4	K/W
Thermal Resistance Junction – to – Ambient (3)	$R_{\Theta\text{-}JA}$	36,5	K/W
Maximum Solder Temperature	T_{SOLD}	260	°C

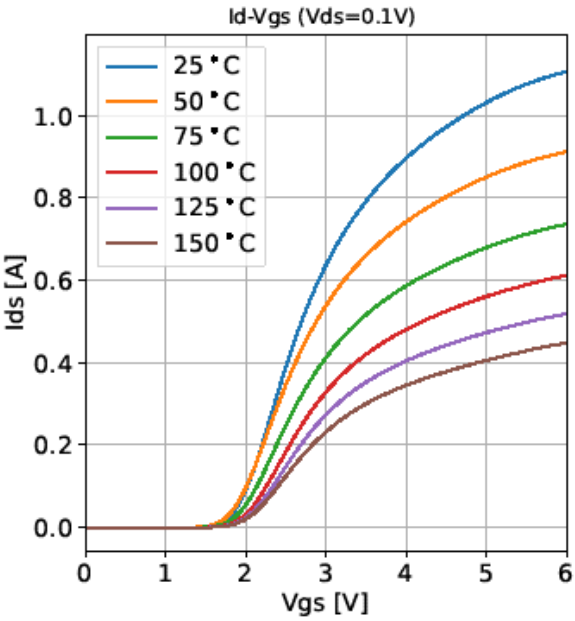
(3) JEDEC JESD51

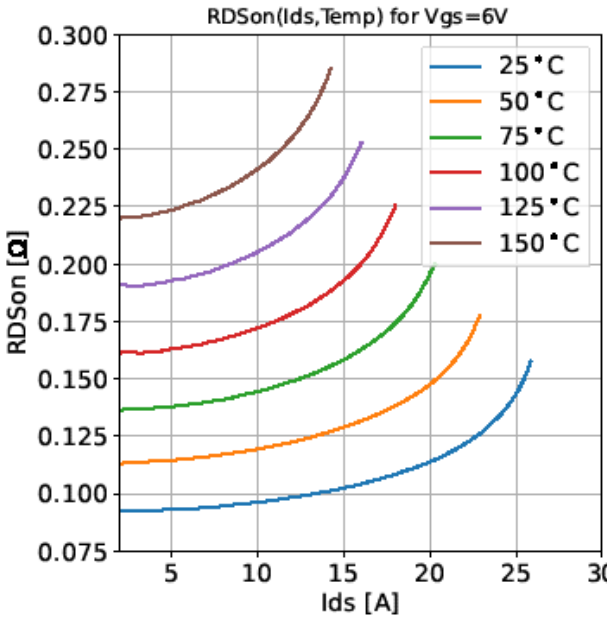
Electrical Characteristics (Typical Values @ T_J = 25°C unless otherwise noted)

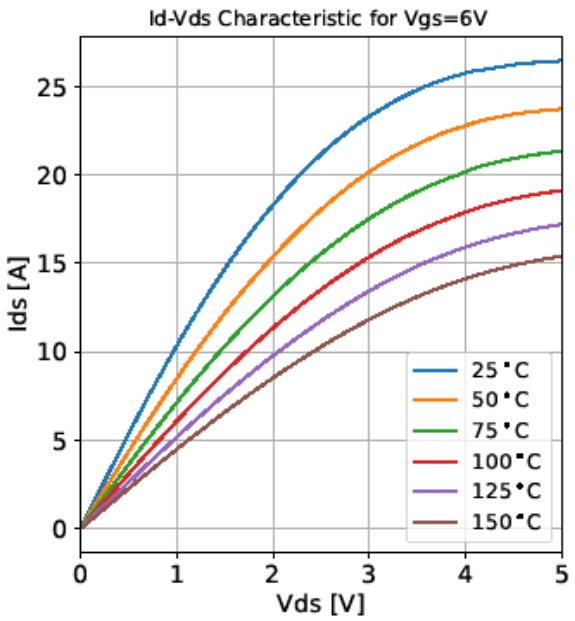
Table 3

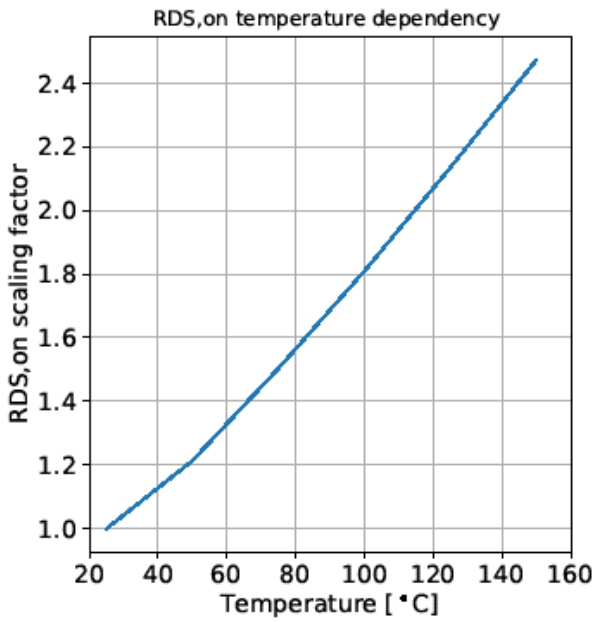
Parameter	Condition	Symbol	Min	Typ	Max	Unit
Drain to Source Blocking Voltage	V_{GS} = 0 V, I_{DSS} ≤ 18 μA	V_{BDSS}	650			V
On Resistance	V_{GS} = 6 V, I_{DS} = 1 A	R_{DSon}		90		mΩ
Gate Threshold Voltage	V_{DS} = V_{GS}, I_{DS} = 14 mA	V_{Th}	0.9	2.0	3.0	V
Gate to Source Current	V_{GS} = 6 V, V_{DS} = 0 V	I_{GS}		480		μA
Drain to Source Leakage Current	V_{DSS} = 650 V, V_{GS} = 0 V	I_{DSS}			7,2	μA
Input Capacitance	V_{DS} = 400 V V_{GS} = 0 V f = 100 kHz	C_{ISS}		132		pF
Output Capacitance		C_{OSS}		72		pF
Reverse Transfer Capacitance		C_{RSS}		0.05		pF
Output Charge	V_{DS} = 400 V, V_{GS} = 0 V	Q_{OSS}		41		nC
Output Cap stored energy	V_{DS} = 400 V V_{GS} = 0 V, f = 100 kHz	E_{OSS}		6.5		μJ
Total Gate Charge	Vds = 0 to 400 V, Vgs = 0 to 6 V	Qg		3.1		nC
Effective Output Capacitance, Energy related	Vds = 0 to 400 V, Vgs = 0 V	$Co_{(er)}$		81		pF
Effective Output Capacitance, Time related	Vds = 0 to 400 V, Vgs = 0 V	$Co_{(tr)}$		102		pF

Electrical Graphs (1/2)

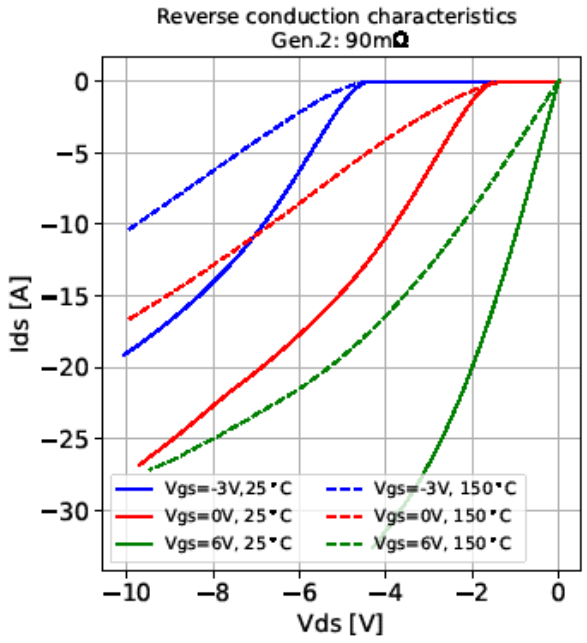


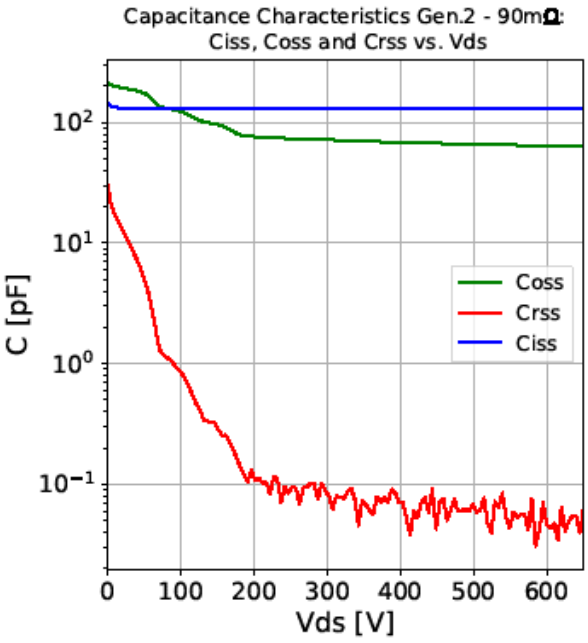


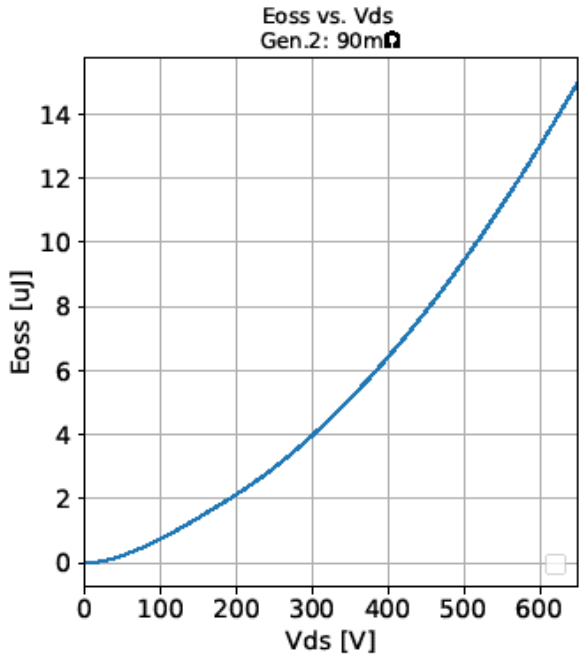


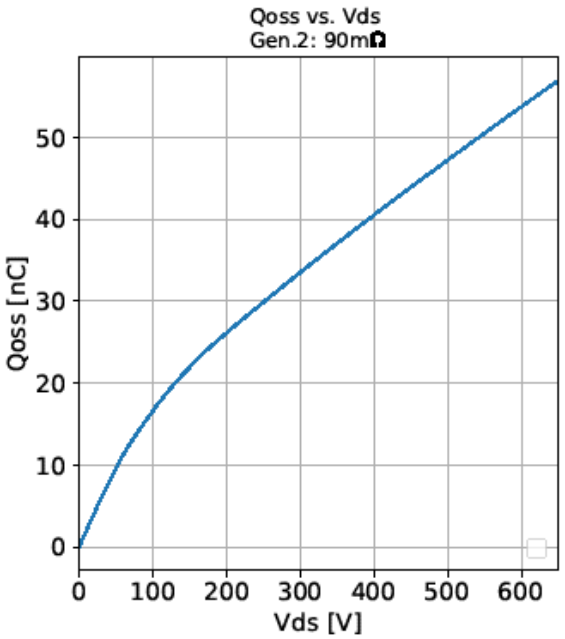


Electrical Graphs (2/2)









Test Circuits

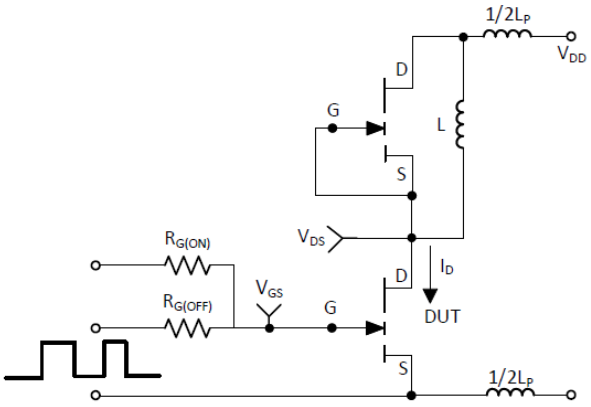


Fig 13: Switching Test Circuit

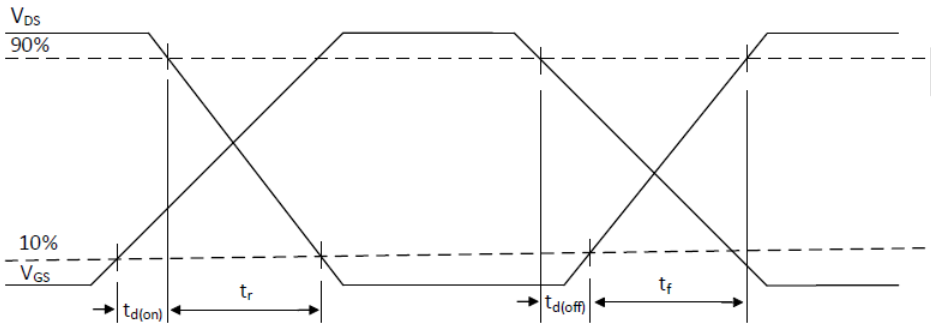
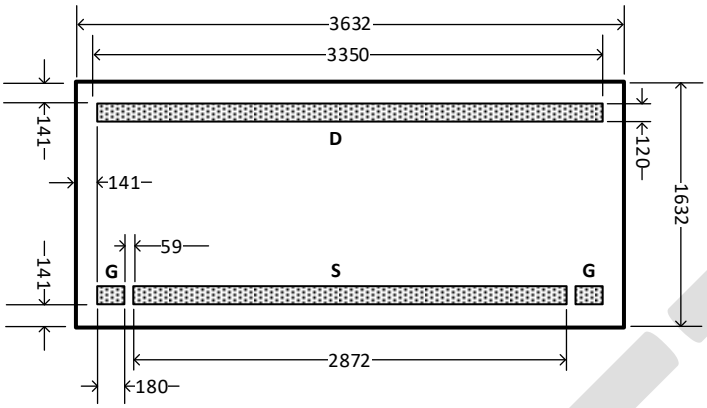


Fig 14: Switching Time Waveforms

Package Information

Bare Die

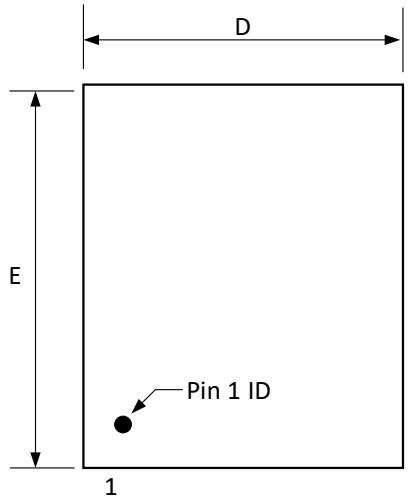
Dimensions of the pads in μm refer to the passivation and polyimide opening.
Drawing is not to scale.



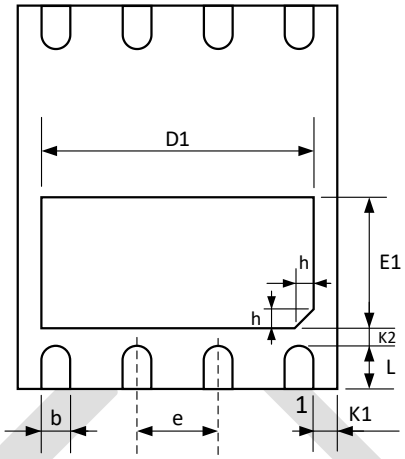
Marking

DFN 5x6 outline

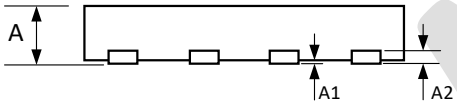
Top view



Bottom view

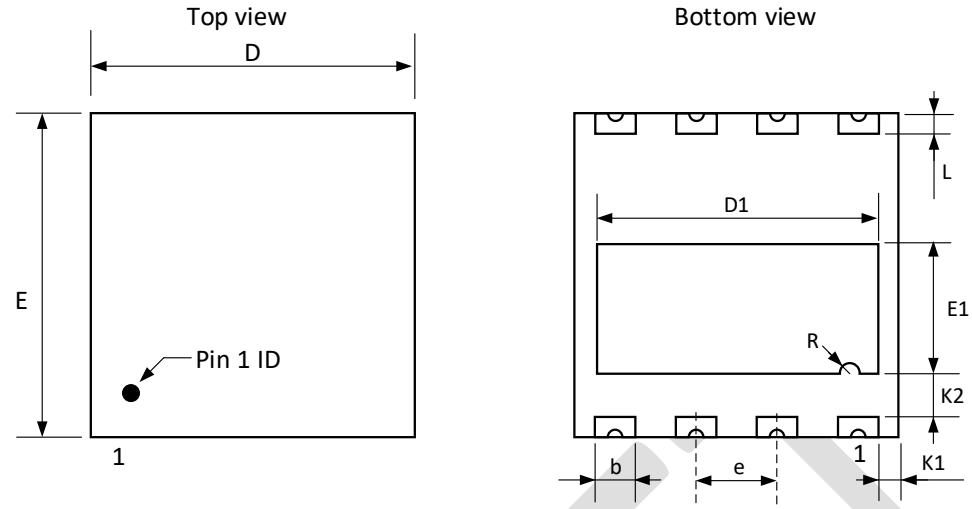


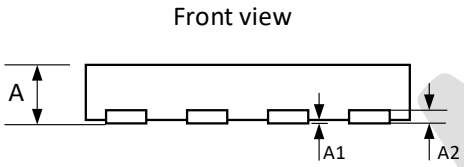
Front view



	Symbol	Min	Typ	Max
Total thickness	A	0.80	0.85	0.90
Stand off	A1	0.00	0.02	0.05
L/F thickness	A2		0.203	
Lead width	b	0.40	0.45	0.50
Body size X	D	4.90	5.00	5.10
EP size X	D1	4.16	4.26	4.36
Body size Y	E	5.90	6.00	6.10
EP size Y	E1	1.95	2.05	2.15
Lead pitch	e		1.27	
Lead length	L	0.575	0.675	0.775
Camfer	h	0.20	0.30	0.40
Gap between lead and pkg	K1	0.80	0.27	0.80
Gap between lead and pad	K2		0.40	

DFN 8x8 outline





	Symbol	Min	Typ	Max
Total thickness	A	0.80	0.85	0.90
Stand off	A1	0.00	0.03	0.05
L/F thickness	A2		0.203	
Lead width	b	0.95	1.00	1.05
Body size X	D	7.90	8.00	7.90
EP size X	D1	6.84	6.94	7.04
Body size Y	E	7.90	8.00	7.90
EP size Y	E1	3.10	3.20	3.30
Lead pitch	e		2.00	
Lead length	L	0.575	0.675	0.775
Radius	R	0.20	0.30	0.40
Gap between lead and pkg	K1	0.40	0.50	0.60
Gap between lead and pad	K2	0.15	0.25	0.35

Disclaimer

This Product Sample is not a finished product and is not available for sale to consumers. The Product Sample is only intended for research, development, demonstration, and evaluation purposes and will only be used in laboratory/development areas by persons with an engineering/technical training and familiar with the risks associated with handling electrical/mechanical components, systems and subsystems. These persons assume full responsibility/liability for proper and safe handling of the Product Sample. Any other use, resale or redistribution of the Product Sample for any other purpose is strictly prohibited.